

Application/Control No. 10/520,760

Examiner Nathan Wiehe Applicant(s)/Patent under Reexamination
ASHIHARA ET AL.

Art Unit 3745

	OR	GINAL		INTERNATIONAL CLASSIFICATION										
	CLASS	CLASS CLAIMED					N			ON-CLAIMED				
	415	1	F	04	D	29	/18				/			
	CROSS R	EFERENCES	F	04	D	29	/66				,			
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Nathan Wiehe 11/21/06 (Assistant Examiner) (Date)					Qk RD K. I	.00K		Total Claims Allowed: 3						
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Claims renumbered in the same order as presented by applicant											□СРА			☐ T.D.			☐ R.1.47		
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